

Report No : CE/2007/60455A LT SEMICONDUCTOR INC.

NO.3, CREATION RD. II, SCIENCE-BASED Date : 2007/06/10

INDUSTRIAL PARK, HSINCHU, TAIWAN, R.O.C. : 1 of 2 Page

The following merchandise was(were) submitted and identified by the client as:

Type of Product REGULATOR IC Style/Item No HT2106 SOT-89-5

Sample Received : 2007/06/03.

Testing Date 2007/06/03 TO 2007/06/10

Test Result : - Please see the next page -

ned for and on behalf of SGS TAIWAN LTD.



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Test Result

MIXED BLACK PLASTIC AND SILVER COLORED METAL PART NAME NO.1

Test Item(s):	Unit	Method	MDL	Result				
				NO.1				
PBBs(Polybrominated biphenyls)(CAS NO:67774-32-7)	%	With reference to 83/264/EEC. Analysis was performed by GC/MS/ECD or HPLC/DAD/MS.	0.0005	N.D.				
PBBEs(PBDEs)(Polybromi nated biphenyl ethers)	%	With reference to 83/264/EEC. Analysis was performed by GC/MS/ECD or HPLC/DAD/MS.	0.0005	N.D.				

				Result				
Test Item(s):	Unit	Method	MDL	NO.1				
Chromium VI (Cr+6)	ppm	As per US EPA 7196A and US EPA 3060A.	2	N.D.				
Cadmium (Cd)	ppm	ICP-AES After As per EN 1122, Method B:2001 or other acid digestion.	2	N.D.				
Mercury (Hg)	ppm	ICP-AES After As per US EPA 3052 or other acid digestion.	2	N.D.				
Lead (Pb)	ppm	ICP-AES After As per US EPA 3050B or other acid digestion.	2	15.0				

NOTE: (1) N.D. = Not detected.(<MDL)

(2) ppm = mg/kg

(3) MDL= Method Detection Limit